Search Notes				

Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/525,515	KARP ET AL.	
Examiner	Art Unit	
Alain L. Bashore	1762	

SEARCHED			
Subclass	Date	Examiner	
35, 37	2/21/2006	AB	
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	Subclass		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
705	35, 37	2/21/2006	AB	
- "				

SEARCH N (INCLUDING SEARC		')
	DATE	EXMR
previous search updated	2/21/2006	АВ
DIALOG search (attached)	3/9/2006	АВ